Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/698,252	CHANG ET AL.	
Examiner	Art Unit	
Lynette T. Umez-Eronini	1765	

	SEAR	CHED	
Class	Subclass	Date	Examiner
438	745	9/17/2005	LTUE
134	2	9/17/2005	LTUE
252	79.1	9/17/2005	LTUE
252	79.2	9/17/2005	LTUE
252	79.3	9/17/2005	LTUE
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INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST (Inventors' search)	9/17/2005	LTUE		
EAST (Inventors' search)	9/22/2005	LTUE		
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